

MT4914

Dual N-Ch PowerTrench[®] SyncFET[™] **General Description**

The MT4914 is designed to replace two single SO-8 MOSFETs and Schottky diode in synchronous DC:DC power supplies that provide various peripheral voltages for notebook computers and other battery powered electronic devices. MT4914 contains two unique 30V, N-channel, logic level, PowerTrench MOSFETs designed to maximize power conversion efficiency.

The high-side switch (Q1) is designed with specific emphasis on reducing switching losses while the lowside switch (Q2) is optimized to reduce conduction losses. Q2 also includes an integrated Schottky diode using MOS-TECH's monolithic SyncFET technology.

Q2:

Features

Optimized to minimize conduction losses Includes SyncFET Schottky body diode

 $R_{DS(on)} = 18 \text{ m}\Omega @ V_{GS} = 10V$ 8.5 A, 30V

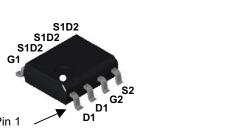
 $R_{DS(on)} = 25 \text{ m}\Omega @ V_{GS} = 4.5 \text{V}$

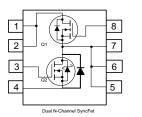
Q1: Optimized for low switching losses Low Gate Charge (11nC typical)

8.5 A, 30V $R_{DS(on)}$ = 18 m Ω @ V_{GS} = 10V

 $R_{DS(on)} = 25 \, m\Omega @ V_{GS} = 4.5V$

100% R_G (Gate Resistance) Tested **RoHS** Compliant





12mm

Absolute Maximum Ratings T_A = 25°C unless otherwise noted

MT4914

Symbol	Parameter		Q2	Q1	Units
V _{DSS}	Drain-Source Voltage		30	30	V
V _{GSS}	Gate-Source Voltage		±20	±20	V
l _D	Drain Current - Continuous	(Note 1a)	8.5	8.5	А
	- Pulsed		30	30	
PD	Power Dissipation for Dual Operation		2		W
	Power Dissipation for Single Operation (Note 1a)		1.6		
		(Note 1b)		1	
		(Note 1c)	0	.9	
T _J , T _{STG}	Operating and Storage Junction Temperat	ure Range	-55 to +150		°C
	I Characteristics			0	
$R_{ heta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78		°C/W
R _{eJC}	Thermal Resistance, Junction-to-Case (Note 1)		40		°C/W

13'

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MT4914

SO-8

Pin 1

MT4914 Rev B(2)

2500 units

	ractoristics	•					Units
	Drain-Source Breakdown	$V_{GS} = 0 V, I_D = 1 mA$	Q2	30			V
	Voltage Breakdown Voltage	$V_{GS} = 0 V$, $I_D = 250 uA$ $I_D = 10 mA$, Referenced to 25°C	Q1 Q2	30	27		mV/°C
ΔT_J	Temperature Coefficient	$I_D = 250 \ \mu A$, Referenced to $25^{\circ}C$	Q1		22		1110/ 0
	Zero Gate Voltage Drain Current	$V_{DS} = 24 V$, $V_{GS} = 0 V$	Q2 Q1			500 1	μΑ
GSS	Gate-Body Leakage	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	Q2 Q1			±100	nA
On Char	racteristics (Note 2)						
V _{GS(th)}	Gate Threshold Voltage	$\begin{array}{ll} V_{DS} = V_{GS}, & I_D = 1 \text{ mA} \\ V_{DS} = V_{GS}, & I_D = 250 \mu\text{A} \end{array}$	Q2 Q1	1 1	1.9 1.9	3 3	V
	Gate Threshold Voltage	I_D = 10 mA, Referenced to 25°C	Q2		-3.2		mV/°C
ΔT_{J}	Temperature Coefficient	I_D = 250 uA, Referenced to 25°C	Q1		-4.2		
= = ()	Static Drain-Source	$V_{GS} = 10 V$, $I_D = 8.2 A$	Q2		18	20	mΩ
	On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 8.2 \text{ A}, T_J = 125^{\circ}\text{C}$ $V_{GS} = 4.5 \text{ V}, I_D = 7.6 \text{ A}$			23 25	36 27	
		$V_{GS} = 10 \text{ V}, I_D = 6.9 \text{ A}$	Q1		18	20	
		$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 6.9 \text{ A}, \text{ T}_{J} = 125^{\circ}\text{C}$			23 25	36 27	
I _{D(on)}	On-State Drain Current	$V_{GS} = 4.5 V, I_D = 6.2 A$ $V_{GS} = 10 V, V_{DS} = 5 V$	Q2 Q1	30 30			А
g _{FS}	Forward Transconductance	$V_{DS} = 5 V$, $I_D = 8.2 A$ $V_{DS} = 5 V$, $I_D = 6.9 A$	Q1 Q2 Q1	50	25 21		S
Dynami	c Characteristics		Q				
	Input Capacitance	V _{DS} = 15 V, V _{GS} = 0 V,	Q2		570		pF
		f = 1.0 MHz	Q1		600		
C _{oss}	Output Capacitance		Q2 Q1		180 150		pF
C _{rss}	Reverse Transfer Capacitance		Q2		70		pF
R _G	Gate Resistance		Q1 Q2		70 2.8	4.9	Ω
3			Q1		2.2	3.8	
	g Characteristics (Note 2	2)					
t _{d(on)}	Turn-On Delay Time		Q2 Q1		10 9	19 18	ns
t _r	Turn-On Rise Time		Q2		5	10	ns
•		$V_{DD} = 15 \text{ V}, I_D = 1 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{\text{GEN}} = 6 \Omega$	Q1		4	8	
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10V, R_{GEN} = 0.22$	Q2 Q1		26 23	42 32	ns
t _f	Turn-Off Fall Time		Q2 Q1		3 3	6 6	ns
t _{d(on)}	Turn-On Delay Time		Q2 Q1		11 10	20 19	ns
t _r	Turn-On Rise Time	- V _{DD} = 15 V, I _D = 1 A,	Q2 Q1		15 9	27 18	ns
t _{d(off)}	Turn-Off Delay Time	$V_{\text{DD}} = 1.5 \text{ V}, \text{H}_{\text{D}} = 1.7 \text{ A}, \text{V}_{\text{GS}} = 4.5 \text{ V}, \text{ R}_{\text{GEN}} = 6 \Omega$	Q2		16	29	ns
t _f	Turn-Off Fall Time	-	Q1 Q2		14 6	25 12	ns
			Q1		4	8	

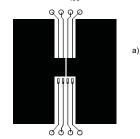
MT4914 Dual N-Channel PowerTrench® MOSFET

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Мах	Units
Switchi	ng Characteristics (Note 2)					
Q _{g(TOT)}	Total Gate Charge at Vgs=10V	Q2: V _{DS} = 15 V, I _D = 8.2A	Q2 Q1		10 11	15 15	nC
Q _g	Total Gate Charge at Vgs=5V	Q1: $V_{DS} = 15 \text{ V}, I_D = 6.9\text{ A}$	Q2 Q1		5.8 6.1	8.2 8.5	nC
Q _{gs}	Gate-Source Charge		Q2 Q1		1.6 1.7		nC
Q _{gd}	Gate–Drain Charge		Q2 Q1		2.1		nC
Drain-S	Source Diode Characteri	stics and Maximum Rating	IS				
ls	Maximum Continuous Drain-Sc	ource Diode Forward Current	Q2 Q1			2.3 1.3	A
Trr	Reverse Recovery Time	I _F = 8.2 A,	Q2		15		ns
Q _{rr}	Reverse Recovery Charge	$d_{iF}/d_t = 300 \text{ A}/\mu \text{s} \qquad (\text{Note 3})$			6		nC
Trr	Reverse Recovery Time	I _F = 6.9 A,	Q1		19		ns
Q _{rr}	Reverse Recovery Charge	$d_{iF}/d_t = 100 \text{ A}/\mu \text{s} \qquad (\text{Note 3})$			10		nC
V _{SD}	Drain-Source Diode Forward Voltage		Q2 Q2 Q1		0.6 0.7 0.7	0.7 1.0 1.2	V

Notes:

1. R_{0LA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0LC} is guaranteed by design while R_{0CA} is determined by the user's board design.

b)



78°C/W when mounted on a 0.5in² pad of 2 oz copper



125°C/W when mounted on a 0.02 in² pad of 2 oz copper c)

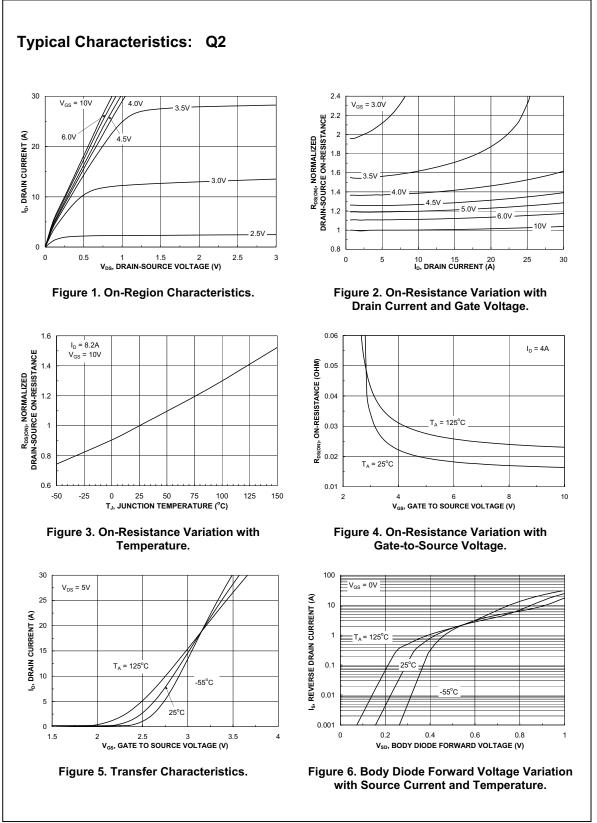
135°C/W when mounted on a minimum pad.

Scale 1 : 1 on letter size paper

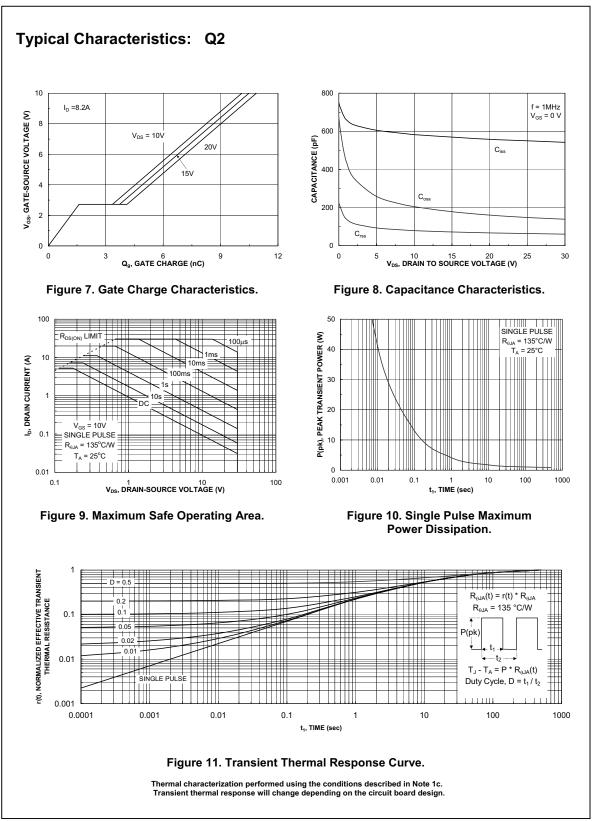
2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

3. See "SyncFET Schottky body diode characteristics" below.

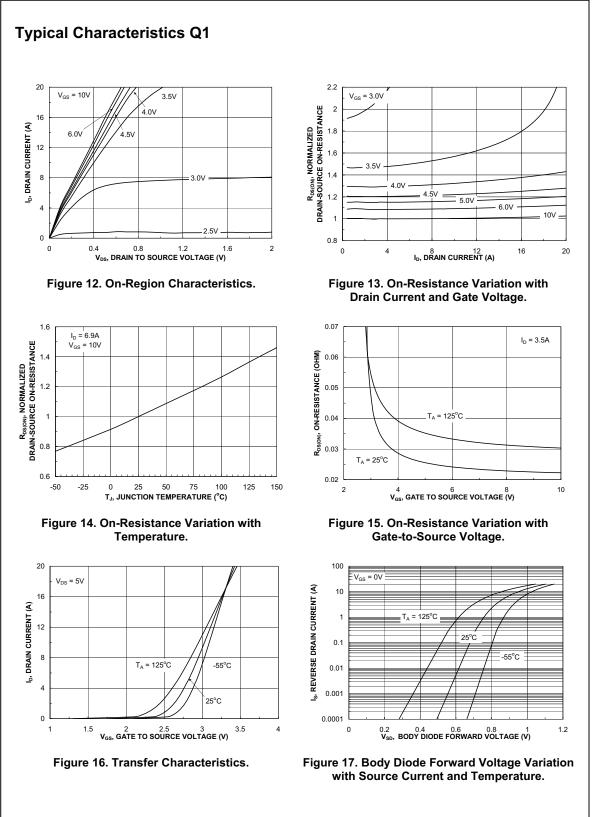
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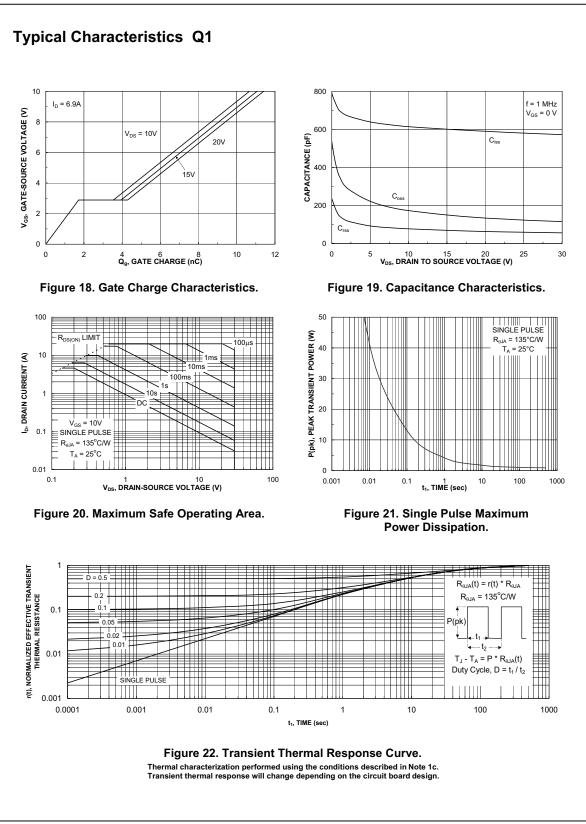
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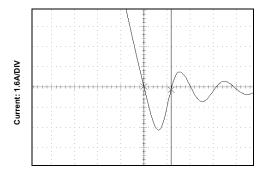




Typical Characteristics (continued)

SyncFET Schottky Body Diode Characteristics

Mos-tech's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. **Figure 23** shows the reverse recovery characteristic of the MT4914.



Time: 10nS/DIV

Figure 23. MT4914 SyncFET body diode reverse recovery characteristic.

For comparison purposes, **Figure 24** shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET (MT4914).

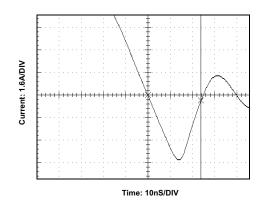


Figure 24. Non-SyncFET (MT4914) body diode reverse recovery characteristic.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

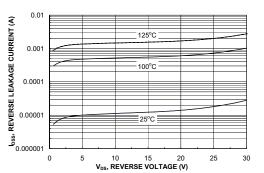
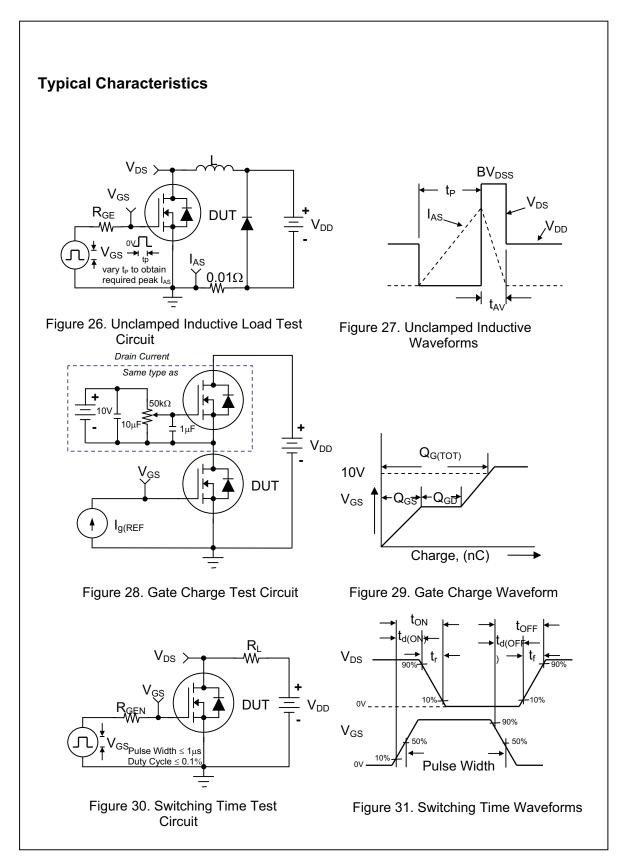


Figure 25. SyncFET body diode reverse leakage versus drain-source voltage and temperature





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